

<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>		Docket Number (Optional) <b>TWI-5440</b>		Application Number <b>NEW</b>	
		Applicant(s) <b>David E. Aspnes et al.</b>			
		Filing Date <b>HEREWITH</b>		Group Art Unit <b>Unknown</b>	

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*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
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REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	No

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	*BC	A. Ambirajan et al., "Optimum Angles for a Polarimeter: Part I," <i>Optical Engineering</i> , Vol. 34, No. 6, pp. 1651-1655, June 1995.
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Examiner <i>Frederick S. Lee</i>	Date Considered <i>11/16/01</i>
Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	